Search Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/817,195	QUINONES ET AL.	
Examiner	Art Unit	
Patrick   Lee	2878	

	SEAR	CHED	
Class	Subclass	Date	Examiner
250	214.1, 239, 551	10/16/05 14/06 2/23/06	PL
257	80-82		PL
257	723, 738		PL
257	783, 790	4	PL
Updated	search	7/5/2006	PL
Updated	search	10/30/2006	PL

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
	nce search ched	10/30/2006	PL

SEARCH NOT (INCLUDING SEARCH		)
	DATE	EXMR
Consulted w/ S. Allen AU 2878 CI 250	10/18/2005	PL
250/214.1, 239, 551; 257/80-82, 723, 738, 783, 790 (see East printout attached)	10/18/2005	PL
East (see attached) - USPAT, US- PGPUB, EPO, JPO, DERWENT	2/21/2006	PL .
East (see attached) - USPAT, US- PGPUB, EPO, JPO, DERWENT	2/23/2006	PL
East (see attached) - USPAT, US- PGPUB, EPO, JPO, DERWENT	7/5/2006	PL <sub>.</sub>
East (see attached) - USPAT, US- PGPUB, EPO, JPO, DERWENT	10/30/2006	PL